

Refine Search

Search Results -

Terms	Documents
(semiconductor same stack) and (stack same test\$)	447

Database:

US Pre-Grant Publication Full-Text Database
US Patents Full-Text Database
US OCR Full-Text Database
EPO Abstracts Database
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Search:

L2

Refine Search

Recall Text 

Clear

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Search History

DATE: Tuesday, September 07, 2004 [Printable Copy](#) [Create Case](#)

Set Name Query
side by side

Hit Count Set Name
result set

DB=USPT; PLUR=YES; OP=ADJ

L2 (semiconductor same stack) and (stack same test\$) 447 L2

DB=DWPI; PLUR=YES; OP=ADJ

L1 (semiconductor same stack) and (stack same test\$) 41 L1

END OF SEARCH HISTORY